



The GreenMOS<sup>®</sup> high voltage MOSFET utilizes charge balance technology to achieve outstanding low on-resistance and lower gate charge. It is engineered to minimize conduction loss, provide superior switching performance and robust avalanche capability.

The GreenMOS<sup>®</sup> Generic series is optimized for extreme switching performance to minimize switching loss. It is tailored for high power density applications to meet the highest efficiency standards.



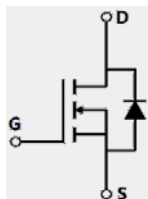
- Low  $R_{DS(ON)}$  & FOM
- Extremely low switching loss
- Excellent stability and uniformity



- PC power
- LED lighting
- Telecom power
- Server power
- EV Charger
- Solar/UPS

$V_{DS, min} @ T_{j(max)}$	600	V
$I_D, pulse$	69	A
$R_{DS(ON), max} @ V_{GS}=10V$	140	m
$Q_g$	24.1	nC

OSG55R140FF	TO220F	OSG55R140F



at  $T_j=25^\circ\text{C}$  unless otherwise noted

Drain-source voltage	$V_{DS}$	550	V
Gate-source voltage	$V_{GS}$	$\pm 30$	V
Continuous drain current <sup>1)</sup> , $T_C=25^\circ\text{C}$	$I_D$	23	A
Continuous drain current <sup>1)</sup> , $T_C=100^\circ\text{C}$		14.5	
Pulsed drain current <sup>2)</sup> , $T_C=25^\circ\text{C}$	$I_{D, pulse}$	69	A
Continuous diode forward current <sup>1)</sup> , $T_C=25^\circ\text{C}$	$I_S$	23	A
Diode pulsed current <sup>2)</sup> , $T_C=25^\circ\text{C}$	$I_{S, pulse}$	69	A
Power dissipation <sup>3)</sup> , $T_C=25^\circ\text{C}$	$P_D$	59.5	W
Single pulsed avalanche energy <sup>5)</sup>	$E_{AS}$	330	mJ
MOSFET dv/dt ruggedness, $V_{DS}=0\dots 480\text{ V}$	dv/dt	50	V/ns
Reverse diode dv/dt, $V_{DS}=0\dots 480\text{ V}$ , $I_{SD} = I_D$	dv/dt	15	V/ns
Operation and storage temperature	$T_{stg}, T_j$	-55 to 150	$^\circ\text{C}$

Thermal resistance, junction-case	$R_{JC}$	2.1	$^\circ\text{C/W}$
Thermal resistance, junction-ambient <sup>4)</sup>	$R_{JA}$	62.5	$^\circ\text{C/W}$

 at  $T_j=25^\circ\text{C}$  unless otherwise specified

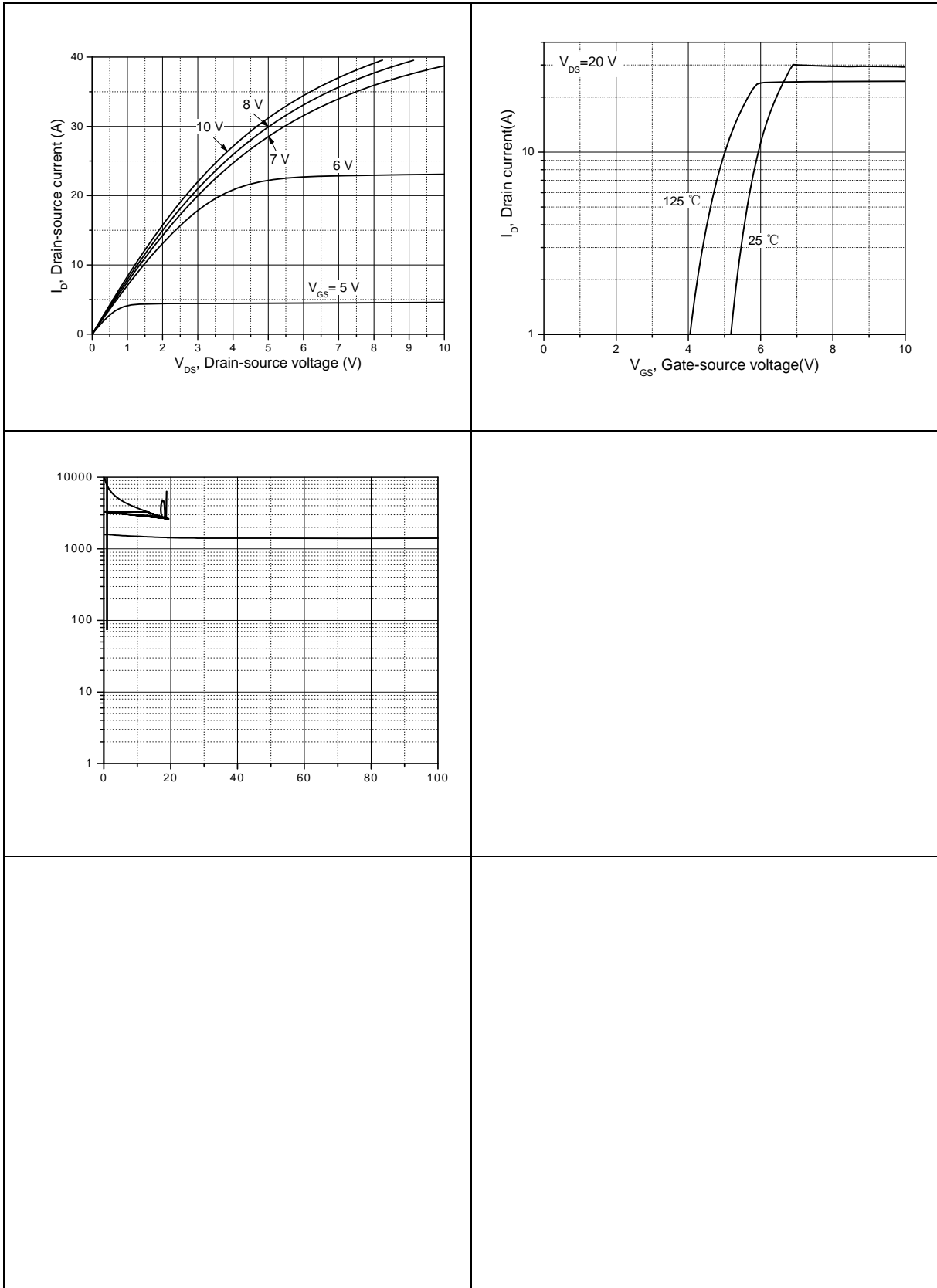
Drain-source breakdown voltage	$BV_{DSS}$	550			V	$V_{GS}=0\text{ V}$ , $I_D=250\text{ }\mu\text{A}$
		600	670			$V_{GS}=0\text{ V}$ , $I_D=250\text{ }\mu\text{A}$ , $T_j=150^\circ\text{C}$
Gate threshold voltage	$V_{GS(th)}$	2		4	V	$V_{DS}=V_{GS}$ , $I_D=250\text{ }\mu\text{A}$
Drain-source on-state resistance	$R_{DS(on)}$		0.11	0.14		$V_{GS}=10\text{ V}$ , $I_D=11.5\text{ A}$
				0.34		$V_{GS}=10\text{ V}$ , $I_D=11.5\text{ A}$ , $T_j=150^\circ\text{C}$
Gate-source leakage current	$I_{GSS}$			100	nA	$V_{GS}=30\text{ V}$
						-100
Drain-source leakage current	$I_{DSS}$			1	$\mu\text{A}$	$V_{DS}=550\text{ V}$ , $V_{GS}=0\text{ V}$

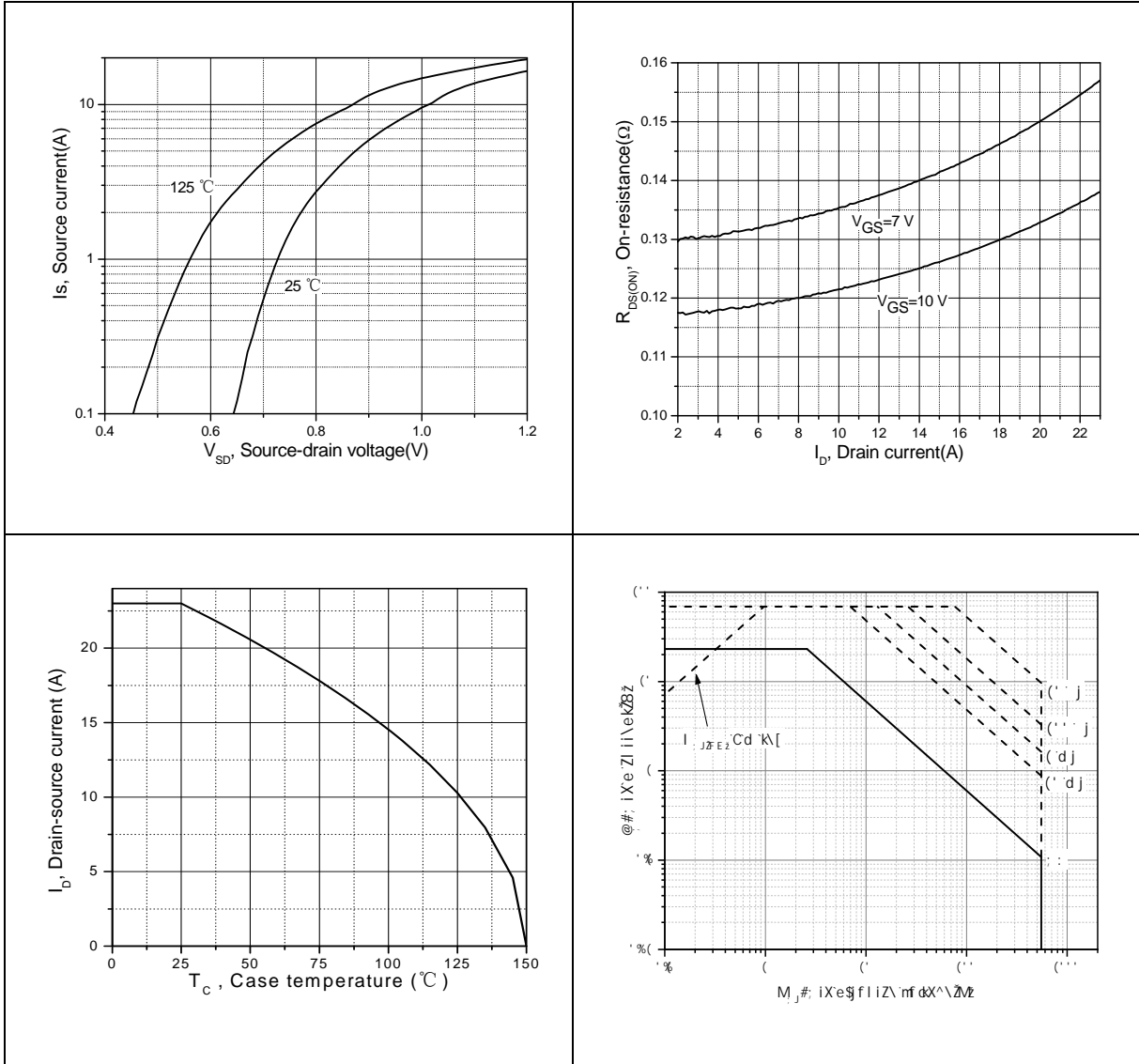
Input capacitance	$C_{iss}$	1408.8	pF	$V_{GS}=0\text{ V}$ , $V_{DS}=50\text{ V}$ , $f=1\text{ MHz}$
Output capacitance	$C_{oss}$	151.2	pF	
Reverse transfer capacitance	$C_{rss}$	4.14	pF	
Turn-on delay time	$t_{d(on)}$	40.5	ns	$V_{GS}=10\text{ V}$ , $V_{DS}=420\text{ V}$ , $R_G=25\ \Omega$ , $I_D=23\text{ A}$
Rise time	$t_r$	73.5	ns	
Turn-off delay time	$t_{d(off)}$	63.6	ns	
Fall time	$t_f$	73.5	ns	

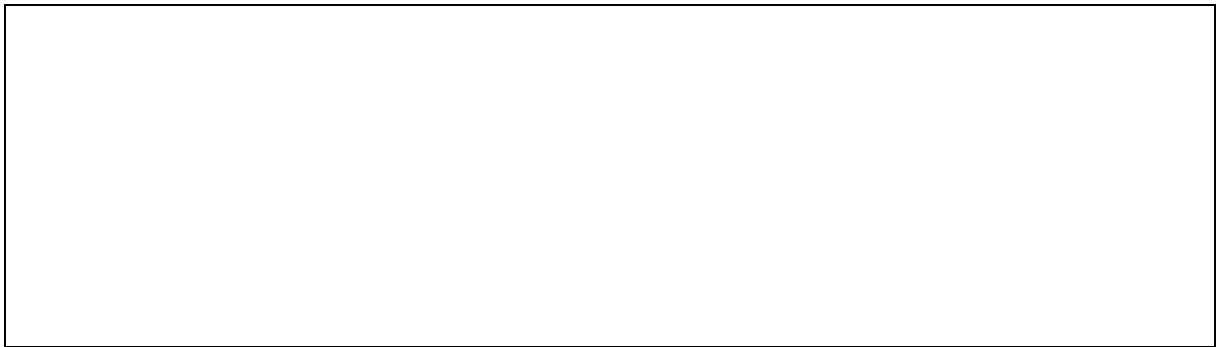
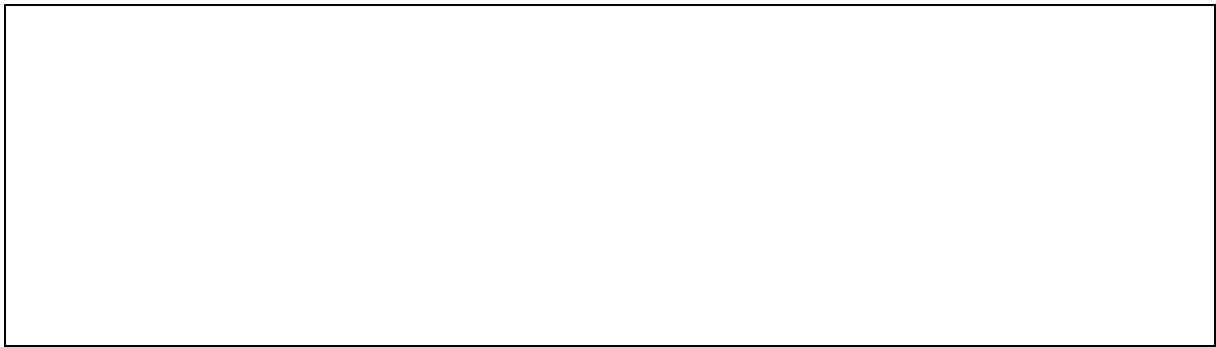
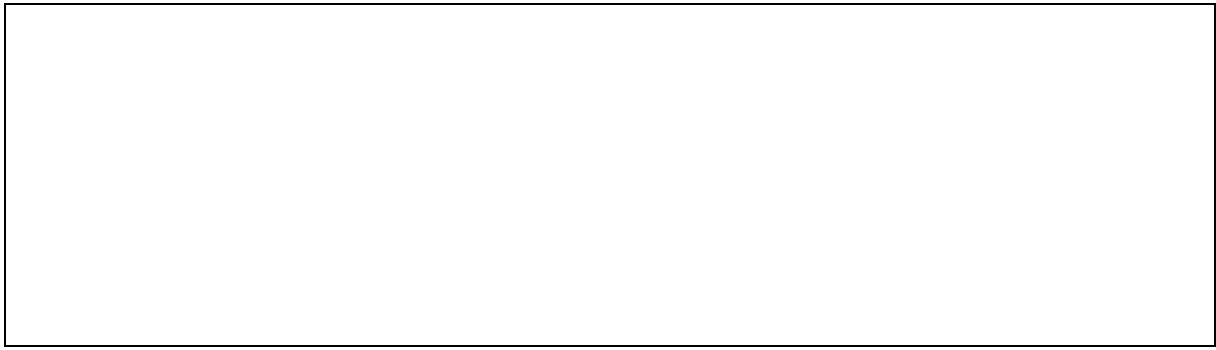
Total gate charge	$Q_g$	24.1	nC	$V_{GS}=10\text{ V}$ , $V_{DS}=420\text{ V}$ , $I_D=23\text{ A}$
Gate-source charge	$Q_{gs}$	9	nC	
Gate-drain charge	$Q_{gd}$	7.4	nC	
Gate plateau voltage	$V_{plateau}$	5.6	V	

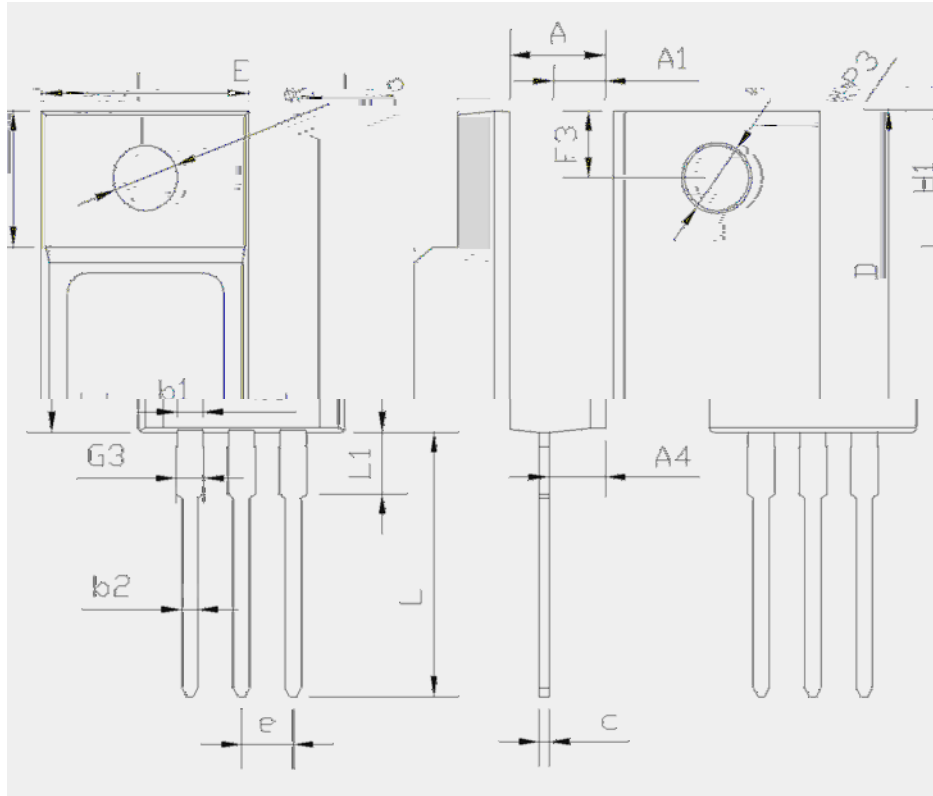
Diode forward voltage	$V_{SD}$	1.4	V	$I_S=23\text{ A}$ , $V_{GS}=0\text{ V}$
Reverse recovery time	$t_{rr}$	372	ns	$V_R=400\text{ V}$ , $I_S=23\text{ A}$ , $di/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge	$Q_{rr}$	5.1	$\mu\text{C}$	
Peak reverse recovery current	$I_{rrm}$	25.6	A	

- 1) Calculated continuous current based on maximum allowable junction temperature.
- 2) Repetitive rating; pulse width limited by max. junction temperature.
- 3)  $P_d$  is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of  $R_{JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_a=25\text{ }^\circ\text{C}$ .
- 5)  $V_{DD}=100\text{ V}$ ,  $V_{GS}=10\text{ V}$ ,  $L=80\text{ mH}$ , starting  $T_j=25\text{ }^\circ\text{C}$ .



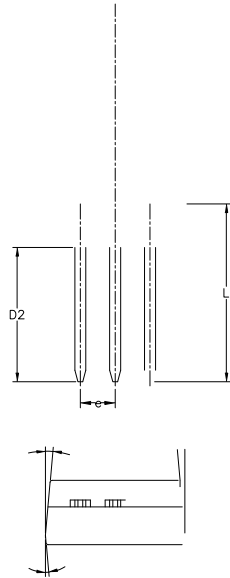






Symbol	mm		
	Min	Nom	Max
E	9.96	10.16	10.36
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A4	2.56	2.76	2.96
c	0.40	0.50	0.65
D	15.57	15.87	16.17
H1	6.70 REF		
e	2.54 BSC		
L	12.68	12.98	13.28
L1	2.88	3.03	3.18
P	3.03	3.18	3.38
P3	3.15	3.45	3.65
F3	3.15	3.30	3.45
G3	1.25	1.35	1.55
b1	1.18	1.28	1.43
b2	0.70	0.80	0.95

Version 1: TO220F-C outline dimension



Symbol	mm		
	Min	Nom	Max
A	4.50	4.70	4.83
A1	2.34	2.54	2.74
A2	0.70 REF		
A3	2.56	2.76	2.93
b	0.70	-	0.90
b1	1.18	-	1.38
b2	-	-	1.47
c	0.45	0.50	0.60
D	15.67	15.87	16.07
D1	15.55	15.75	15.95
D2	9.60	9.80	10.00
E	9.96	10.16	10.36
e	2.54 BSC		
H1	6.48	6.68	6.88
L	12.68	12.98	13.28
L1	-	-	3.50
L2	6.50 REF		
P	3.08	3.18	3.28
Q	3.20	-	3.40
	1°	3°	5°

Version 2: TO220F-J outline dimension



TO220F-C	50	20	1000	6	6000
TO220F-J	50	20	1000	5	5000

OSG55R140FF	TO220F	yes	yes	yes

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